

IRG4IBC30FDPbF

International
IR Rectifier

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---------------------------------|---|------|------|-----------|---------|---|
| $V_{(BR)CES}$ | Collector-to-Emitter Breakdown Voltage ^③ | 600 | — | — | V | $V_{GE} = 0V, I_C = 250\mu A$ |
| $\Delta V_{(BR)CES}/\Delta T_J$ | Temperature Coeff. of Breakdown Voltage | — | 0.69 | — | V/°C | $V_{GE} = 0V, I_C = 1.0mA$ |
| $V_{CE(on)}$ | Collector-to-Emitter Saturation Voltage | — | 1.59 | 1.8 | V | $I_C = 17A$ $V_{GE} = 15V$ |
| | | — | 1.99 | — | | $I_C = 31A$ See Fig. 2, 5 |
| | | — | 1.70 | — | | $I_C = 17A, T_J = 150^\circ\text{C}$ |
| $V_{GE(th)}$ | Gate Threshold Voltage | 3.0 | — | 6.0 | | $V_{CE} = V_{GE}, I_C = 250\mu A$ |
| $\Delta V_{GE(th)}/\Delta T_J$ | Temperature Coeff. of Threshold Voltage | — | -11 | — | mV/°C | $V_{CE} = V_{GE}, I_C = 250\mu A$ |
| g_{fe} | Forward Transconductance ^④ | 6.1 | 10 | — | S | $V_{CE} = 100V, I_C = 17A$ |
| I_{CES} | Zero Gate Voltage Collector Current | — | — | 250 | μA | $V_{GE} = 0V, V_{CE} = 600V$ |
| | | — | — | 2500 | | $V_{GE} = 0V, V_{CE} = 600V, T_J = 150^\circ\text{C}$ |
| V_{FM} | Diode Forward Voltage Drop | — | 1.4 | 1.7 | V | $I_C = 12A$ See Fig. 13 |
| | | — | 1.3 | 1.6 | | $I_C = 12A, T_J = 150^\circ\text{C}$ |
| I_{GES} | Gate-to-Emitter Leakage Current | — | — | ± 100 | nA | $V_{GE} = \pm 20V$ |

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|------------------|--|------|------|------|------------|--|
| Q_g | Total Gate Charge (turn-on) | — | 51 | 77 | nC | $I_C = 17A$ |
| Q_{ge} | Gate - Emitter Charge (turn-on) | — | 7.9 | 12 | | $V_{CC} = 400V$ See Fig. 8 |
| Q_{gc} | Gate - Collector Charge (turn-on) | — | 19 | 28 | | $V_{GE} = 15V$ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 42 | — | ns | $T_J = 25^\circ\text{C}$ |
| t_r | Rise Time | — | 26 | — | | $I_C = 17A, V_{CC} = 480V$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 230 | 350 | | $V_{GE} = 15V, R_G = 23\Omega$ |
| t_f | Fall Time | — | 160 | 230 | | Energy losses include "tail" and diode reverse recovery. |
| E_{on} | Turn-On Switching Loss | — | 0.63 | — | mJ | See Fig. 9, 10, 11, 18 |
| E_{off} | Turn-Off Switching Loss | — | 1.39 | — | | |
| E_{ts} | Total Switching Loss | — | 2.02 | 3.9 | | |
| $t_{d(on)}$ | Turn-On Delay Time | — | 42 | — | ns | $T_J = 150^\circ\text{C}$, See Fig. 9, 10, 11, 18 |
| t_r | Rise Time | — | 27 | — | | $I_C = 17A, V_{CC} = 480V$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 310 | — | | $V_{GE} = 15V, R_G = 23\Omega$ |
| t_f | Fall Time | — | 310 | — | | Energy losses include "tail" and diode reverse recovery. |
| E_{ts} | Total Switching Loss | — | 3.2 | — | mJ | |
| L_E | Internal Emitter Inductance | — | 7.5 | — | nH | Measured 5mm from package |
| C_{ies} | Input Capacitance | — | 1100 | — | pF | $V_{GE} = 0V$ |
| C_{oes} | Output Capacitance | — | 74 | — | | $V_{CC} = 30V$ See Fig. 7 |
| C_{res} | Reverse Transfer Capacitance | — | 14 | — | | $f = 1.0MHz$ |
| t_{rr} | Diode Reverse Recovery Time | — | 42 | 60 | ns | $T_J = 25^\circ\text{C}$ See Fig. 14 |
| | | — | 80 | 120 | | $T_J = 125^\circ\text{C}$ |
| I_{rr} | Diode Peak Reverse Recovery Current | — | 3.5 | 6.0 | A | $T_J = 25^\circ\text{C}$ See Fig. 15 |
| | | — | 5.6 | 10 | | $T_J = 125^\circ\text{C}$ |
| Q_{rr} | Diode Reverse Recovery Charge | — | 80 | 180 | nC | $T_J = 25^\circ\text{C}$ See Fig. 16 |
| | | — | 220 | 600 | | $T_J = 125^\circ\text{C}$ |
| $di_{(rec)M}/dt$ | Diode Peak Rate of Fall of Recovery During t_b | — | 180 | — | A/ μs | $T_J = 25^\circ\text{C}$ See Fig. 17 |
| | | — | 120 | — | | $T_J = 125^\circ\text{C}$ |

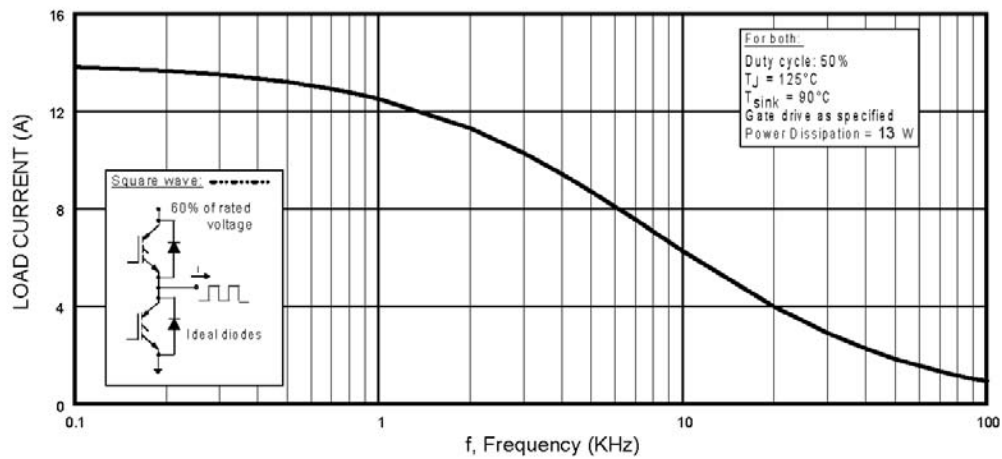


Fig. 1 - Typical Load Current vs. Frequency
(Load Current = I_{RMS} of fundamental)

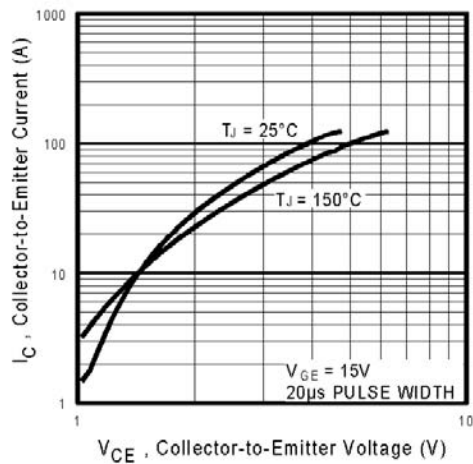


Fig. 2 - Typical Output Characteristics

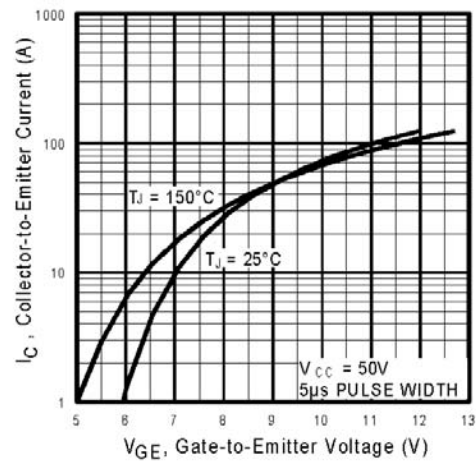


Fig. 3 - Typical Transfer Characteristics

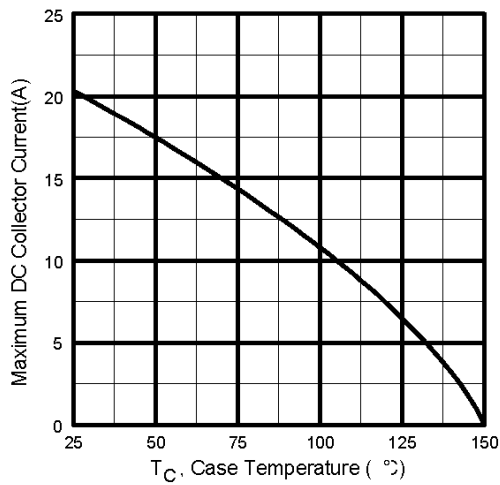


Fig. 4 - Maximum Collector Current vs. Case Temperature

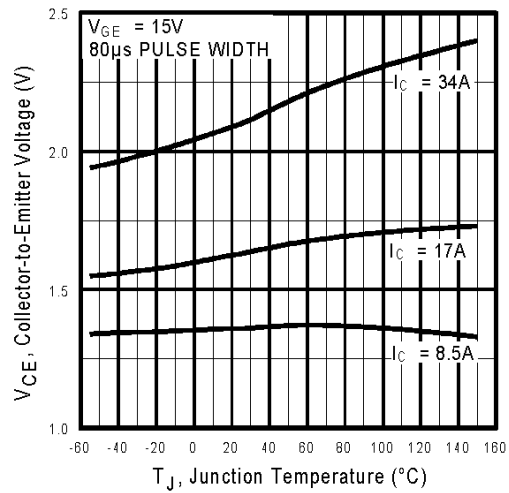


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

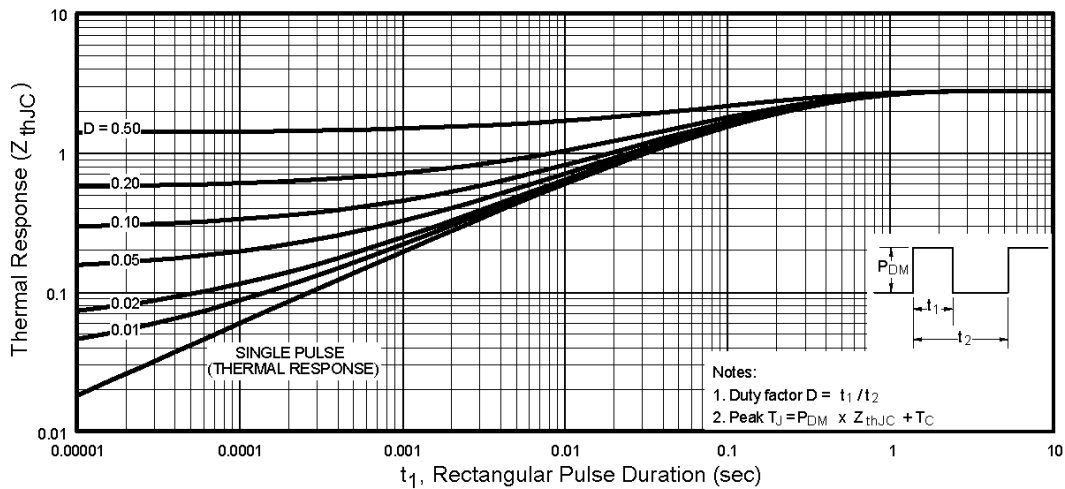


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

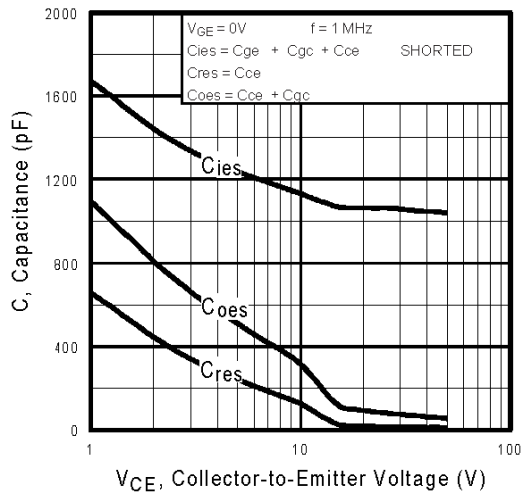


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

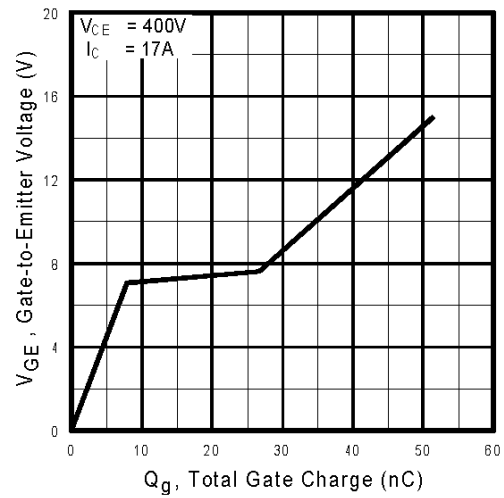


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

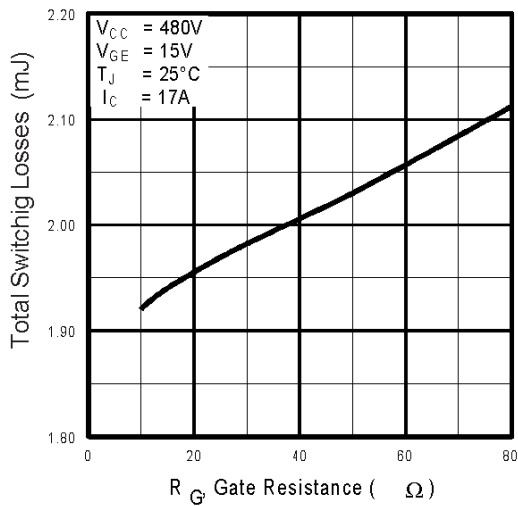


Fig. 9 - Typical Switching Losses vs. Gate Resistance

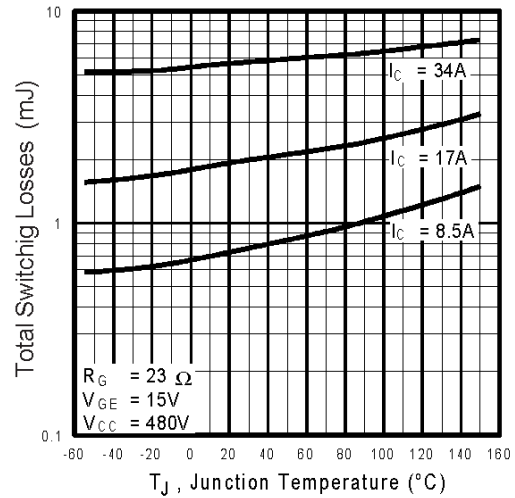
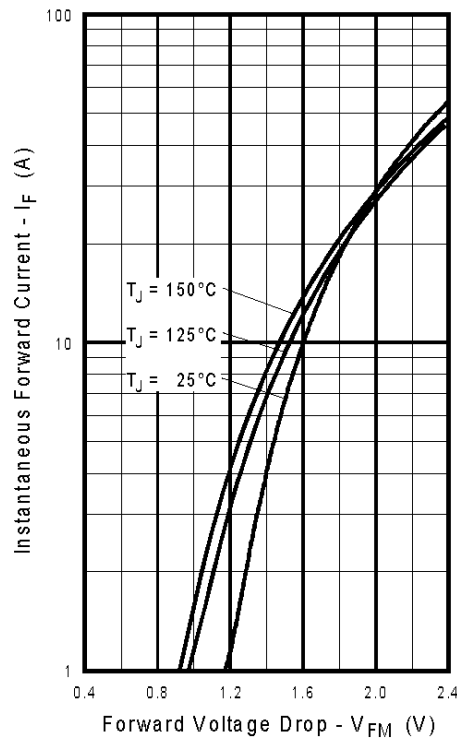
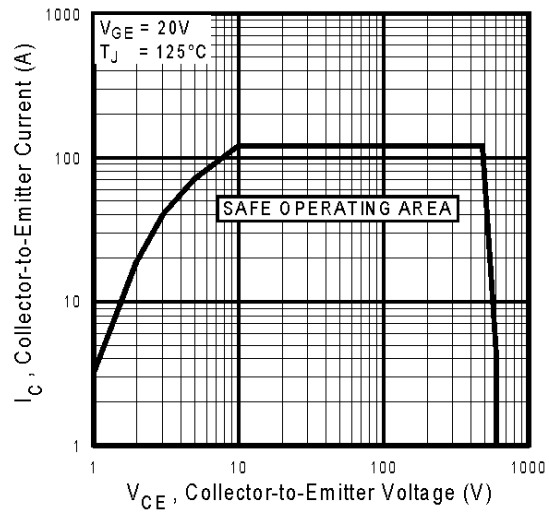
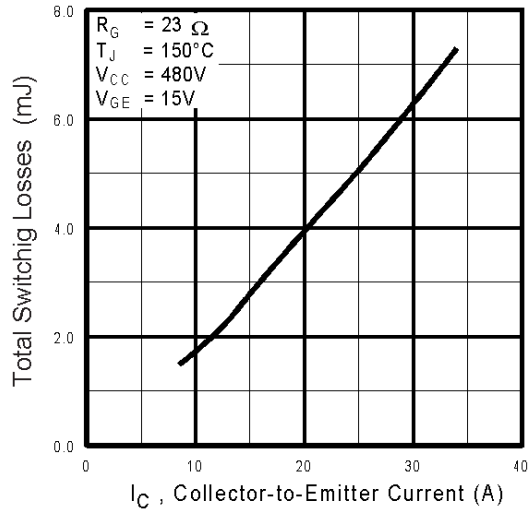


Fig. 10 - Typical Switching Losses vs. Junction Temperature

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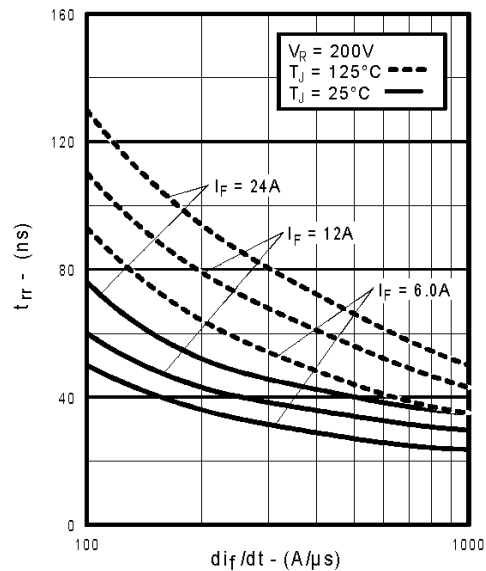


Fig. 14 - Typical Reverse Recovery vs. di/dt

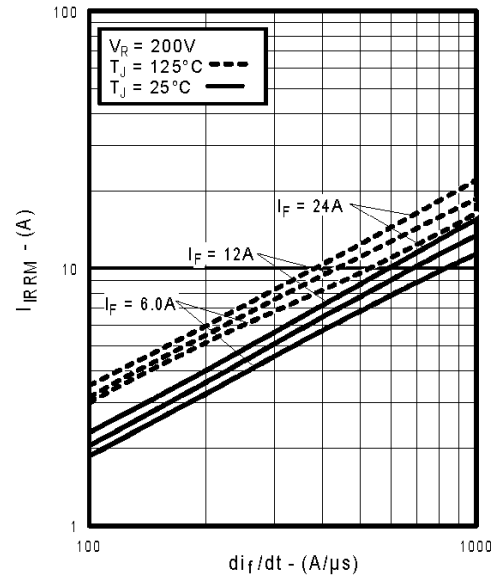


Fig. 15 - Typical Recovery Current vs. di/dt

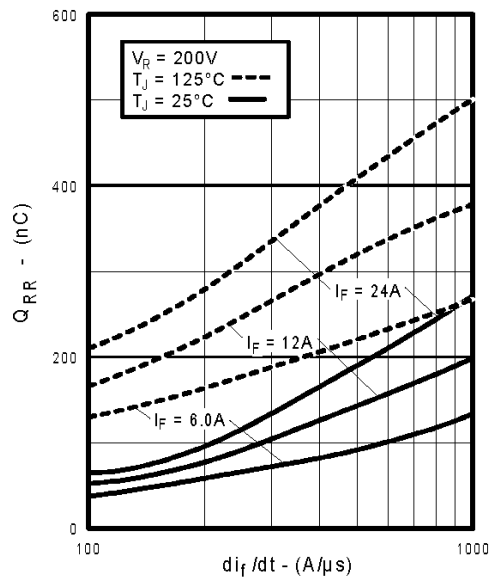


Fig. 16 - Typical Stored Charge vs. di/dt

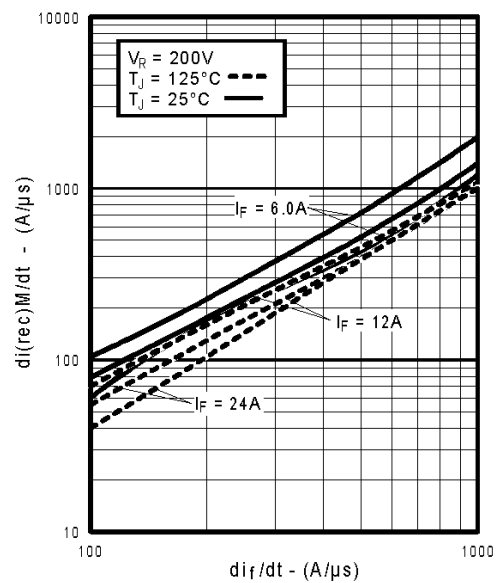


Fig. 17 - Typical $di_{(rec)}M/dt$ vs. di/dt

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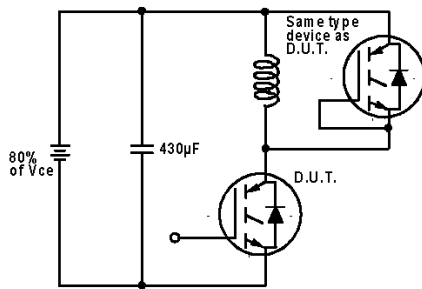


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

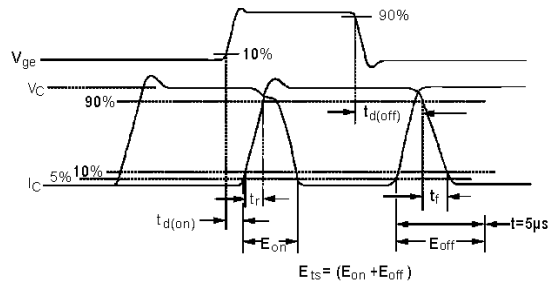


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

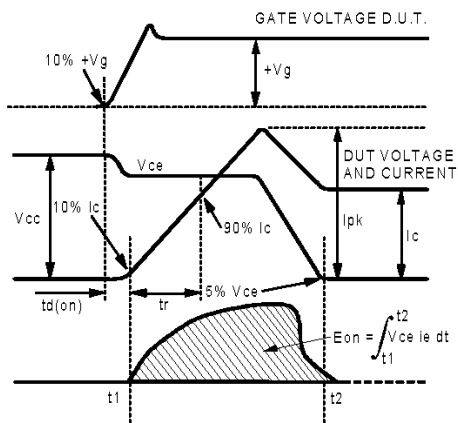


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

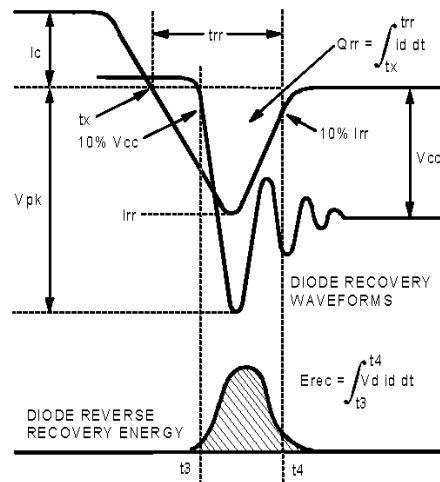


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

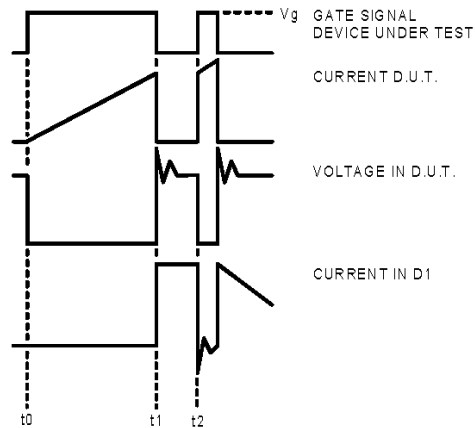


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

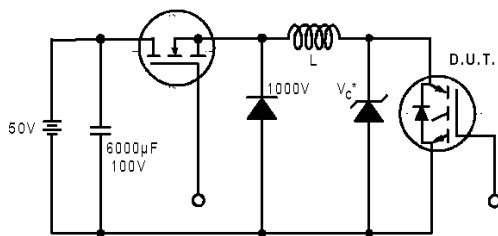


Figure 19. Clamped Inductive Load Test Circuit

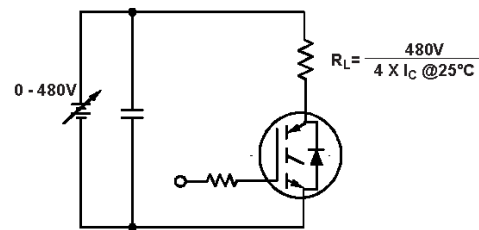


Figure 20. Pulsed Collector Current Test Circuit

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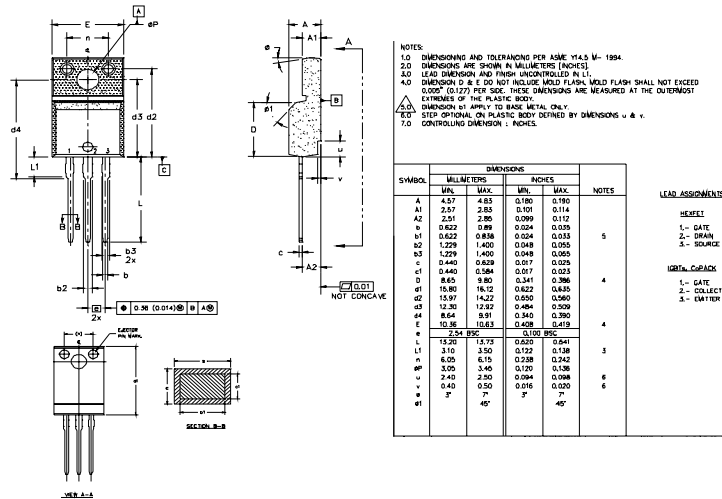
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Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G = 23\Omega$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.
- ⑤ $t = 60s$, $f = 60Hz$

TO-220 Full-Pak Package Outline

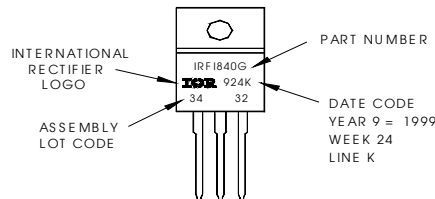
Dimensions are shown in millimeters (inches)



TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRF1840G
WITH ASSEMBLY
LOT CODE 3432
ASSEMBLED ON WW 24 1999
IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



Data and specifications subject to change without notice.

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Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>